

Search Notes 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/667,004	CHAN ET AL.	
				Examiner	Art Unit	
				Frank W. Lu	1634	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
Class	Subclass	Date	Examiner	STN	DATE	EXMR
435	6 7.1 9.1	5/12/2006	m	East (see attached file)	5/12/2006	m
183				Inventor searches update	10/19/2006	m
2831				update	4/12/2007	m
287.1						
287.2						
436	94					
	501					
536	231 24.3					
	24.33					
	2853					
130	300					
	350					
Update		10/19/2006	m			
Update		4/12/2007	m			
INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			